

PTO-1449

Application No.  
09/853,316Applicant(s)  
Takeshi (nmi) Hoshida et al.Information Disclosure Citation  
in an ApplicationDocket Number  
064731.0185Group Art Unit  
2633Filing Date  
May 10, 2001

## U.S. PATENT DOCUMENTS

		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
MC	A	4,794,351	12/27/1988	Darcie	332	7.51	09/29/1986
MC	B	5,355,243	10/11/1994	King	359	190	08/11/1992
MC	C	5,515,196	05/07/1996	Kitajima et al.	359	180	04/02/1993
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							YES	NO
MC	N	JP02000059300A	02/25/2000	Japan	H04B	G01B	X	

		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
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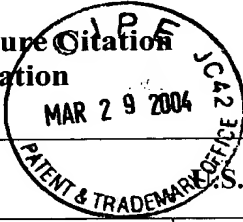
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